

5.0 OR 3.0V, 512 bit (64 x 8) SERIAL RTC and NVRAM SUPERVISOR

FEATURES SUMMARY

- 5.0 OR 3.0V OPERATING VOLTAGE
- SERIAL INTERFACE SUPPORTS I²C BUS (400 KHz)
- NVRAM SUPERVISOR FOR EXTERNAL LPSRAM
- OPTIMIZED FOR MINIMAL INTERCONNECT TO MCU
- 2.5 TO 5.5V OSCILLATOR OPERATING VOLTAGE
- AUTOMATIC SWITCH-OVER and DESELECT CIRCUITRY
- CHOICE OF POWER-FAIL DESELECT VOLTAGES
 - M41ST85Y: $V_{CC} = 4.5$ to $5.5V$; $4.20V \leq V_{PFD} \leq 4.50V$
 - M41ST85W: $V_{CC} = 2.7$ to $3.6V$; $2.55V \leq V_{PFD} \leq 2.70V$
- 1.25V REFERENCE (for PFI/ \overline{PFO})
- COUNTERS FOR TENTHS/HUNDREDTHS OF SECONDS, SECONDS, MINUTES, HOURS, DAY, DATE, MONTH, YEAR, and CENTURY
- 44 BYTES OF GENERAL PURPOSE RAM
- PROGRAMMABLE ALARM and INTERRUPT FUNCTION (VALID EVEN DURING BATTERY BACK-UP MODE)
- WATCHDOG TIMER
- MICROPROCESSOR POWER-ON RESET
- BATTERY LOW FLAG
- POWER-DOWN TIMESTAMP (HT BIT)
- ULTRA-LOW BATTERY SUPPLY CURRENT OF 500nA (MAX)
- PACKAGING INCLUDES A 28-LEAD SOIC and SNAPHAT[®] TOP (to be Ordered Separately)
- SOIC SNAPHAT PACKAGE PROVIDES DIRECT CONNECTION FOR A SNAPHAT TOP WHICH CONTAINS THE BATTERY and CRYSTAL
- SOIC EMBEDDED CRYSTAL PACKAGE (MX) OPTION

Figure 1. 28-pin SOIC Package

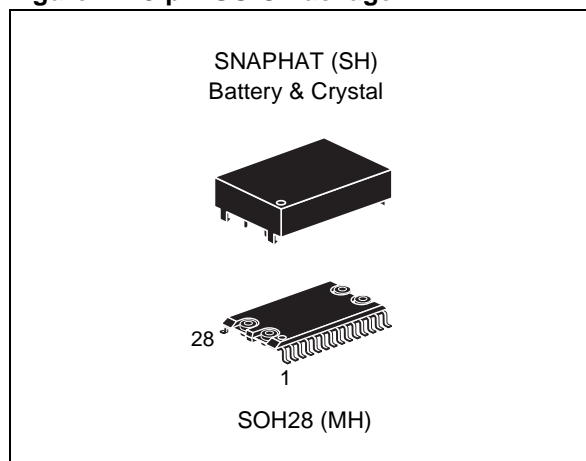


Figure 2. 28-pin (300mil) SOIC Package

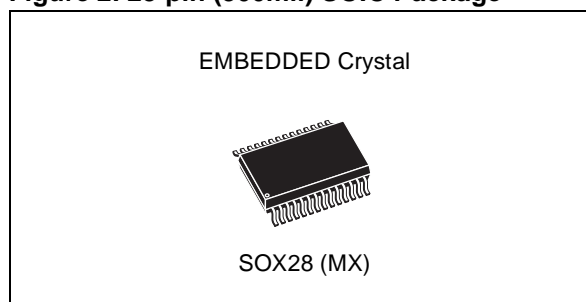


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SUMMARY DESCRIPTION

The M41ST85Y/W Serial TIMEKEEPER®/Controller SRAM is a low power 512-bit, static CMOS SRAM organized as 64 words by 8 bits. A built-in 32.768 kHz oscillator (external crystal controlled) and 8 bytes of the SRAM (see Table 8, page 18) are used for the clock/calendar function and are configured in binary coded decimal (BCD) format.

An additional 12 bytes of RAM provide status/control of Alarm, Watchdog and Square Wave functions. Addresses and data are transferred serially via a two line, bi-directional I²C interface. The built-in address register is incremented automatically after each WRITE or READ data byte. The M41ST85Y/W has a built-in power sense circuit which detects power failures and automatically switches to the battery supply when a power failure occurs. The energy needed to sustain the SRAM and clock operations can be supplied by a small lithium button-cell supply when a power failure occurs.

Functions available to the user include a non-volatile, time-of-day clock/calendar, Alarm interrupts, Watchdog Timer and programmable Square Wave output. Other features include a Power-On Reset as well as two additional debounced inputs (RSTIN1 and RSTIN2) which can also generate an output Reset (RST). The eight clock address locations contain the century, year, month, date, day, hour, minute, second and tenths/hundredths of a second in 24 hour BCD format. Corrections for 28,

29 (leap year - valid until year 2100), 30 and 31 day months are made automatically.

The M41ST85Y/W is supplied in a 28-lead SOIC SNAPHAT® package (which integrates both crystal and battery in a single SNAPHAT top) or a 28-pin, 300mil SOIC package (MX) which includes an embedded 32kHz crystal.

The 28-pin, 330mil SOIC provides sockets with gold plated contacts at both ends for direct connection to a separate SNAPHAT housing containing the battery and crystal. The unique design allows the SNAPHAT battery/crystal package to be mounted on top of the SOIC package after the completion of the surface mount process.

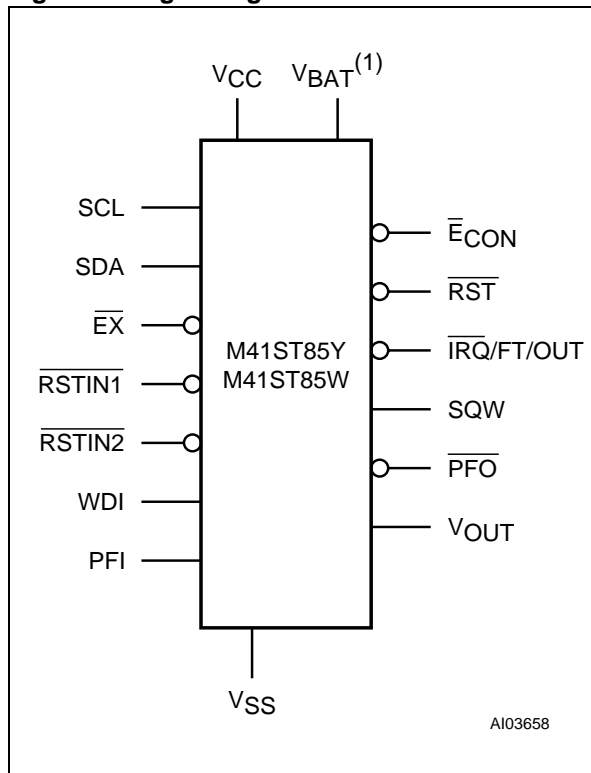
Insertion of the SNAPHAT housing after reflow prevents potential battery and crystal damage due to the high temperatures required for device surface-mounting. The SNAPHAT housing is also keyed to prevent reverse insertion.

The SOIC and battery/crystal packages are shipped separately in plastic anti-static tubes or in Tape & Reel form. For the 28-lead SOIC, the battery/crystal package (e.g., SNAPHAT) part number is "M4TXX-BR12SH" (see Table 15, page 27).

Caution: Do not place the SNAPHAT battery/crystal top in conductive foam, as this will drain the lithium button-cell battery.

The 300mil, embedded crystal SOIC requires only a user-supplied battery to provide non-volatile operation.

Figure 3. Logic Diagram



Note: 1. For 28-pin, 300mil embedded crystal SOIC only.

Table 1. Signal Names

\overline{ECON}	Conditioned Chip Enable Output
\overline{EX}	External Chip Enable
$\overline{IRQ/FT/OUT}$	Interrupt/Frequency Test/Out Output (Open Drain)
PFI	Power Fail Input
\overline{PFO}	Power Fail Output
\overline{RST}	Reset Output (Open Drain)
$\overline{RSTIN1}$	Reset 1 Input
$\overline{RSTIN2}$	Reset 2 Input
SCL	Serial Clock Input
SDA	Serial Data Input/Output
SQW	Square Wave Output
WDI	Watchdog Input
VCC	Supply Voltage
VOUT	Voltage Output
VSS	Ground
$V_{BAT}^{(1)}$	Battery Supply Voltage

Note: 1. For 28-pin, 300mil embedded crystal SOIC only.

Figure 4. 28-pin SOIC Connections

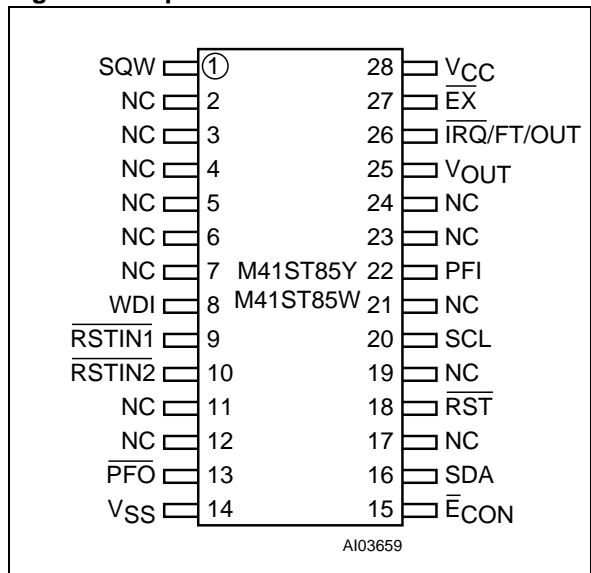


Figure 5. 28-pin, 300mil SOIC (MX) Connections

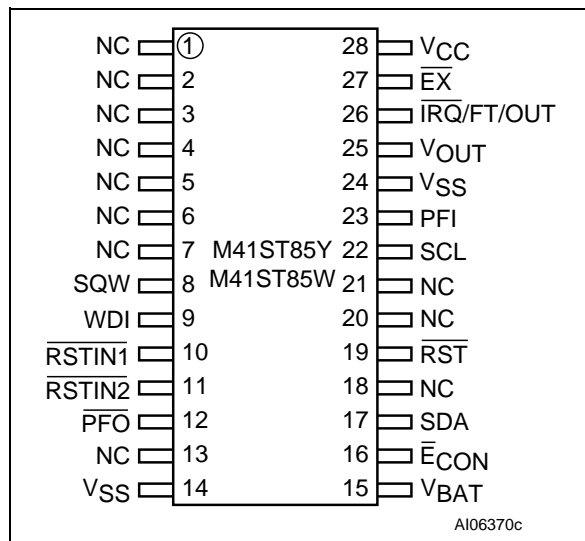
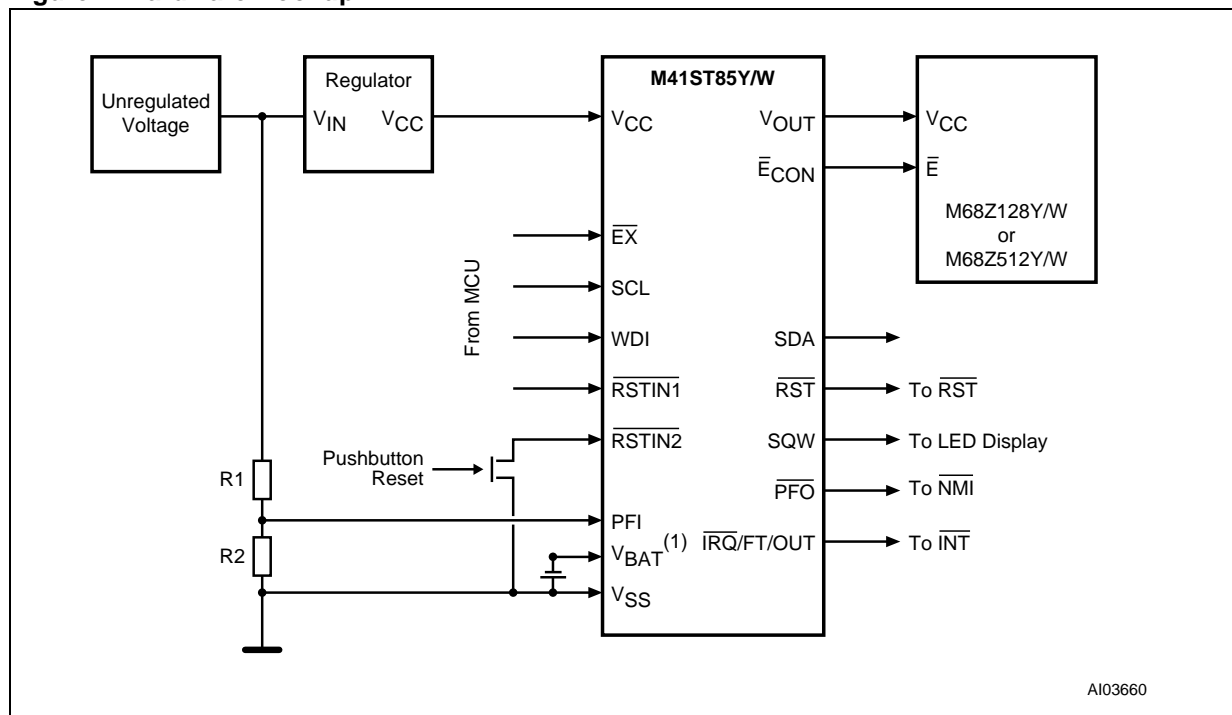


Figure 7. Hardware Hookup



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Note: 1. Required for embedded crystal (MX) package only.

MAXIMUM RATING

Stressing the device above the rating listed in the “Absolute Maximum Ratings” table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is

not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Table 2. Absolute Maximum Ratings

Symbol	Parameter		Value	Unit
T _{STG}	Storage Temperature (V _{CC} Off, Oscillator Off)	SNAPHAT®	–40 to 85	°C
		SOIC	–55 to 125	°C
T _{SLD} ⁽¹⁾	Lead Solder Temperature for 10 seconds		260	°C
V _{IO}	Input or Output Voltage		–0.3 to V _{CC} +0.3	V
V _{CC}	Supply Voltage	M41ST85Y	–0.3 to 7	V
		M41ST85W	–0.3 to 4.6	V
I _O	Output Current		20	mA
P _D	Power Dissipation		1	W

Note: 1. Reflow at peak temperature of 215°C to 225°C for < 60 seconds (total thermal budget not to exceed 180°C for between 90 to 120 seconds).

CAUTION: Negative undershoots below –0.3V are not allowed on any pin while in the Battery Back-up mode.

CAUTION: Do NOT wave solder SOIC to avoid damaging SNAPHAT sockets.

DC AND AC PARAMETERS

This section summarizes the operating and measurement conditions, as well as the DC and AC characteristics of the device. The parameters in the following DC and AC Characteristic tables are derived from tests performed under the Measure-

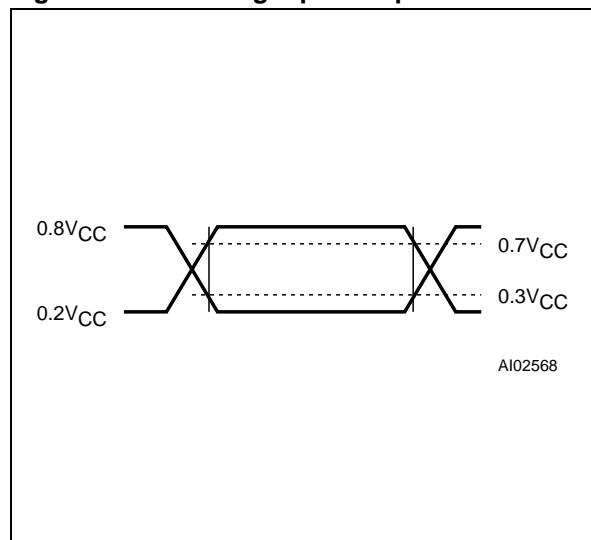
ment Conditions listed in the relevant tables. Designers should check that the operating conditions in their projects match the measurement conditions when using the quoted parameters.

Table 3. DC and AC Measurement Conditions

Parameter	M41ST85Y	M41ST85W
V _{CC} Supply Voltage	4.5 to 5.5V	2.7 to 3.6V
Ambient Operating Temperature	–40 to 85°C	–40 to 85°C
Load Capacitance (C _L)	100pF	50pF
Input Rise and Fall Times	≤ 50ns	≤ 50ns
Input Pulse Voltages	0.2 to 0.8V _{CC}	0.2 to 0.8V _{CC}
Input and Output Timing Ref. Voltages	0.3 to 0.7V _{CC}	0.3 to 0.7V _{CC}

Note: Output High Z is defined as the point where data is no longer driven.

Figure 8. AC Testing Input/Output Waveforms



Note: 50pF for M41ST85W.

Table 4. Capacitance

Symbol	Parameter ^(1,2)	Min	Max	Unit
C _{IN}	Input Capacitance		7	pF
C _{OUT} ⁽³⁾	Output Capacitance		10	pF
t _{LP}	Low-pass filter input time constant (SDA and SCL)		50	ns

Note: 1. Effective capacitance measured with power supply at 5V. Sampled only, not 100% tested.

2. At 25°C, f = 1MHz.

3. Outputs are deselected.

Table 5. DC Characteristics

Sym	Parameter	Test Condition ⁽¹⁾	M41ST85Y			M41ST85W			Unit
			Min	Typ	Max	Min	Typ	Max	
I _{BAT} ⁽²⁾	Battery Current OSC ON	T _A = 25°C, V _{CC} = 0V, V _{BAT} = 3V		400	500		400	500	nA
	Battery Current OSC OFF			50			50		nA
I _{CC1}	Supply Current	f = 400kHz			1.4			0.75	mA
I _{CC2}	Supply Current (Standby)	SCL, SDA = V _{CC} – 0.3V			1			0.50	mA
I _{LI} ⁽³⁾	Input Leakage Current	0V ≤ V _{IN} ≤ V _{CC}			±1			±1	μA
	Input Leakage Current (PFI)		–25	2	25	–25	2	25	nA
I _{LO} ⁽⁴⁾	Output Leakage Current	0V ≤ V _{IN} ≤ V _{CC}			±1			±1	μA
I _{OUT1} ⁽⁵⁾	V _{OUT} Current (Active)	V _{OUT1} > V _{CC} – 0.3V			175			100	mA
I _{OUT2}	V _{OUT} Current (Battery Back-up)	V _{OUT2} > V _{BAT} – 0.3V			100			100	μA
V _{IH}	Input High Voltage		0.7V _{CC}		V _{CC} + 0.3	0.7V _{CC}		V _{CC} + 0.3	V
V _{IL}	Input Low Voltage		–0.3		0.3V _{CC}	–0.3		0.3V _{CC}	V
V _{BAT}	Battery Voltage		2.5	3.0	3.5 ⁽⁹⁾	2.5	3.0	3.5 ⁽⁹⁾	V
V _{OH}	Output High Voltage ⁽⁶⁾	I _{OH} = –1.0mA	2.4			2.4			V
V _{OHB} ⁽⁷⁾	V _{OH} (Battery Back-up)	I _{OUT2} = –1.0μA	2.5	2.9	3.5	2.5	2.9	3.5	V
V _{OL}	Output Low Voltage	I _{OL} = 3.0mA			0.4			0.4	V
	Output Low Voltage (Open Drain) ⁽⁸⁾	I _{OL} = 10mA			0.4			0.4	V
V _{PFD}	Power Fail Deselect		4.20	4.40	4.50	2.55	2.60	2.70	V
V _{PFI}	PFI Input Threshold	V _{CC} = 5V(Y) V _{CC} = 3V(V)	1.225	1.250	1.275	1.225	1.250	1.275	V
	PFI Hysteresis	PFI Rising		20	70		20	70	mV
V _{SO}	Battery Back-up Switchover			2.5			2.5		V

Note: 1. Valid for Ambient Operating Temperature: T_A = –40 to 85°C; V_{CC} = 4.5 to 5.5V or 2.7 to 3.6V (except where noted).

2. Measured with V_{OUT} and E_{CON} open.

3. RSTIN1 and RSTIN2 internally pulled-up to V_{CC} through 100KΩ resistor. WDI internally pulled-down to V_{SS} through 100KΩ resistor.

4. Outputs Deselected.

5. External SRAM must match RTC SUPERVISOR chip V_{CC} specification.

6. For PFO and SQW pins (CMOS).

7. Conditioned output (E_{CON}) can only sustain CMOS leakage current in the battery back-up mode. Higher leakage currents will reduce battery life.

8. For IRQ/FT/OUT, RST pins (Open Drain): if pulled-up to supply other than V_{CC}, this supply must be equal to, or less than 3.0V when V_{CC} = 0V (during battery back-up mode).

9. For rechargeable back-up, V_{BAT} (max) may be considered V_{CC}.

OPERATING MODES

The M41ST85Y/W clock operates as a slave device on the serial bus. Access is obtained by implementing a start condition followed by the correct slave address (D0h). The 64 bytes contained in the device can then be accessed sequentially in the following order:

1. Tenths/Hundredths of a Second Register
2. Seconds Register
3. Minutes Register
4. Century/Hours Register
5. Day Register
6. Date Register
7. Month Register
8. Year Register
9. Control Register
10. Watchdog Register
- 11 - 16. Alarm Registers
- 17 - 19. Reserved
20. Square Wave Register
- 21 - 64. User RAM

The M41ST85Y/W clock continually monitors V_{CC} for an out-of-tolerance condition. Should V_{CC} fall below V_{PFD} , the device terminates an access in progress and resets the device address counter. Inputs to the device will not be recognized at this time to prevent erroneous data from being written to the device from an out-of-tolerance system. When V_{CC} falls below V_{SO} , the device automatically switches over to the battery and powers down into an ultra low current mode of operation to

conserve battery life. As system power returns and V_{CC} rises above V_{SO} , the battery is disconnected, and the power supply is switched to external V_{CC} . Write protection continues until V_{CC} reaches $V_{PFD}(\text{min})$ plus $t_{REC}(\text{min})$.

For more information on Battery Storage Life refer to Application Note AN1012.

2-Wire Bus Characteristics

The bus is intended for communication between different ICs. It consists of two lines: a bi-directional data signal (SDA) and a clock signal (SCL). Both the SDA and SCL lines must be connected to a positive supply voltage via a pull-up resistor.

The following protocol has been defined:

- Data transfer may be initiated only when the bus is not busy.
- During data transfer, the data line must remain stable whenever the clock line is High.
- Changes in the data line, while the clock line is High, will be interpreted as control signals.

Accordingly, the following bus conditions have been defined:

Bus not busy. Both data and clock lines remain High.

Start data transfer. A change in the state of the data line, from High to Low, while the clock is High, defines the START condition.

Stop data transfer. A change in the state of the data line, from Low to High, while the clock is High, defines the STOP condition.

Data Valid. The state of the data line represents valid data when after a start condition, the data line is stable for the duration of the high period of the clock signal. The data on the line may be changed during the Low period of the clock signal. There is one clock pulse per bit of data.

Each data transfer is initiated with a start condition and terminated with a stop condition. The number of data bytes transferred between the start and stop conditions is not limited. The information is transmitted byte-wide and each receiver acknowledges with a ninth bit.

By definition a device that gives out a message is called “transmitter,” the receiving device that gets the message is called “receiver.” The device that controls the message is called “master.” The devices that are controlled by the master are called “slaves.”

Acknowledge. Each byte of eight bits is followed by one Acknowledge Bit. This Acknowledge Bit is a low level put on the bus by the receiver whereas the master generates an extra acknowledge related clock pulse. A slave receiver which is addressed is obliged to generate an acknowledge after the reception of each byte that has been clocked out of the slave transmitter.

The device that acknowledges has to pull down the SDA line during the acknowledge clock pulse in such a way that the SDA line is a stable Low during the High period of the acknowledge related clock pulse. Of course, setup and hold times must be taken into account. A master receiver must signal an end of data to the slave transmitter by not generating an acknowledge on the last byte that has been clocked out of the slave. In this case the transmitter must leave the data line High to enable the master to generate the STOP condition.

Figure 9. Serial Bus Data Transfer Sequence

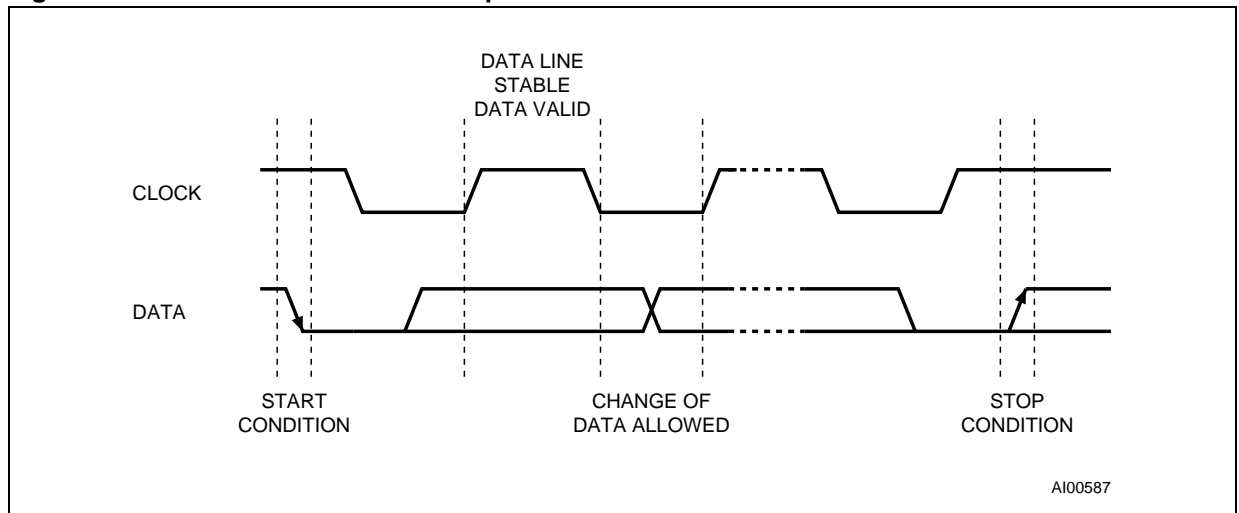


Figure 10. Acknowledgement Sequence

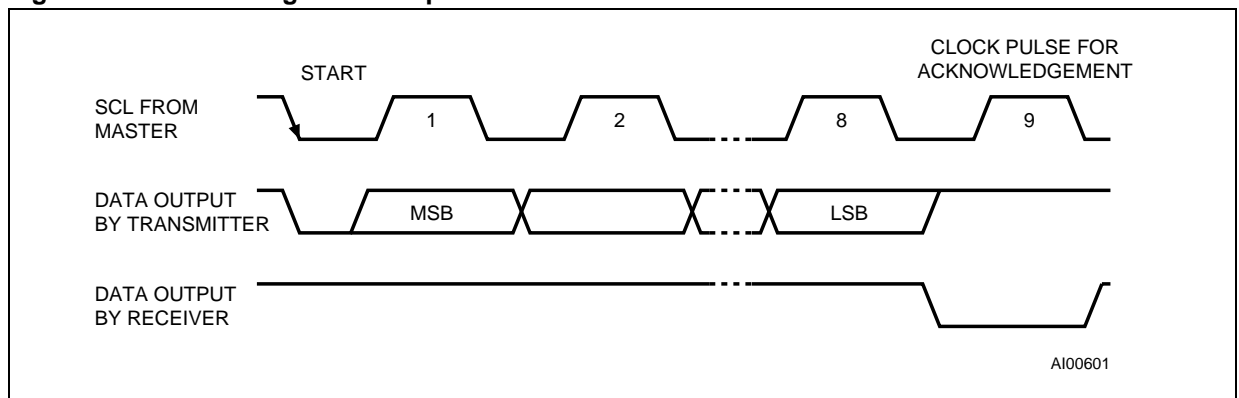
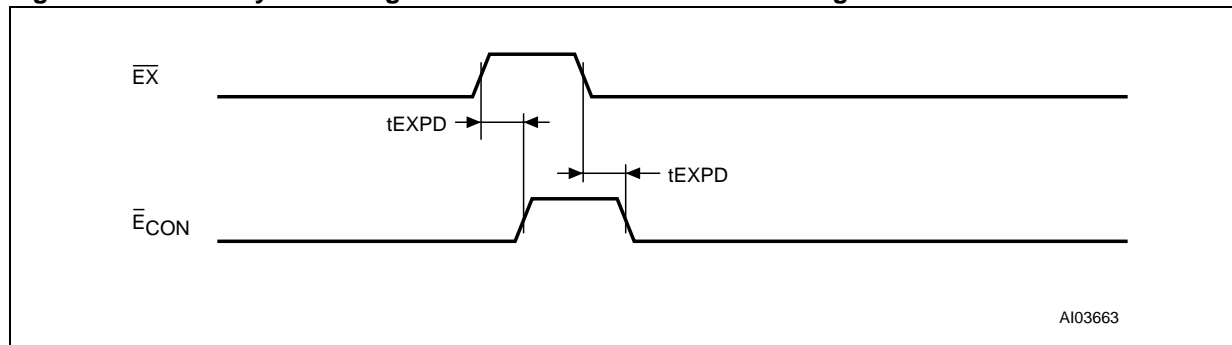
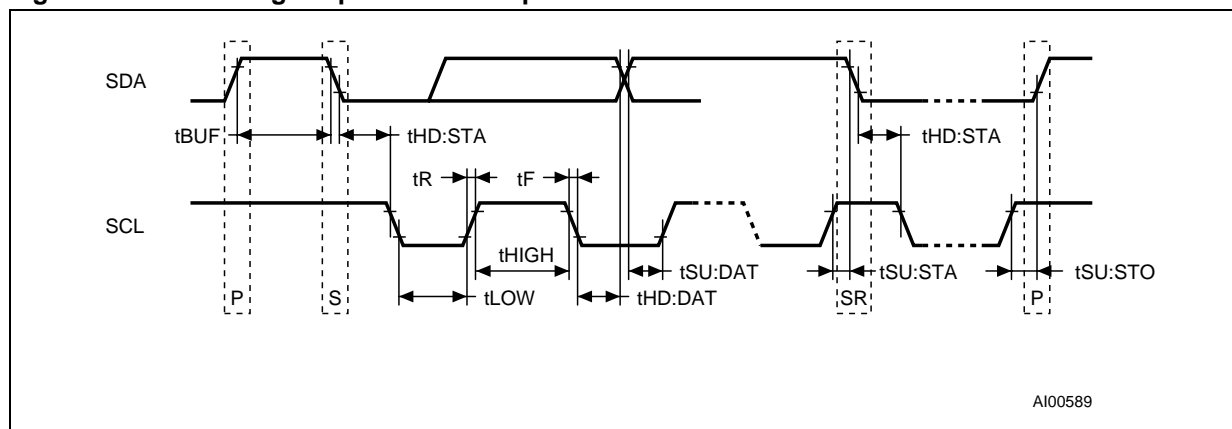
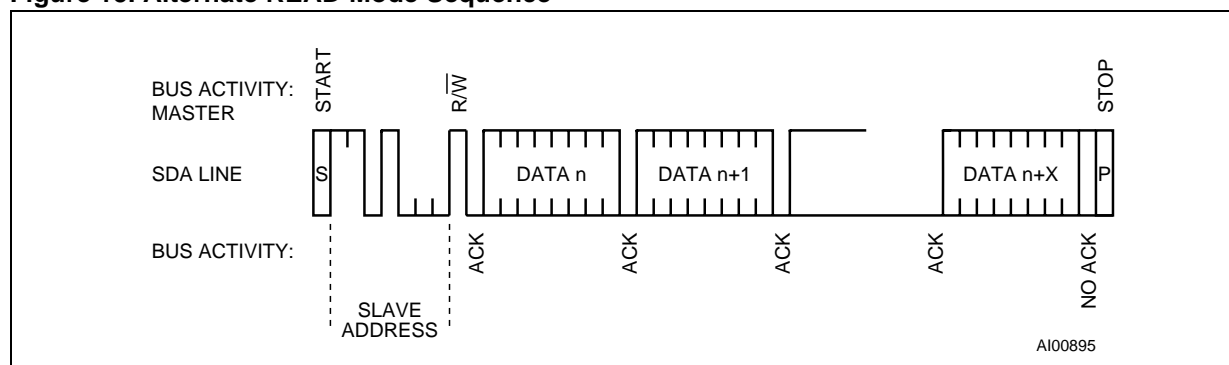


Figure 11. WRITE Cycle Timing: RTC & External SRAM Control Signals

Figure 12. Bus Timing Requirements Sequence

Table 6. AC Characteristics

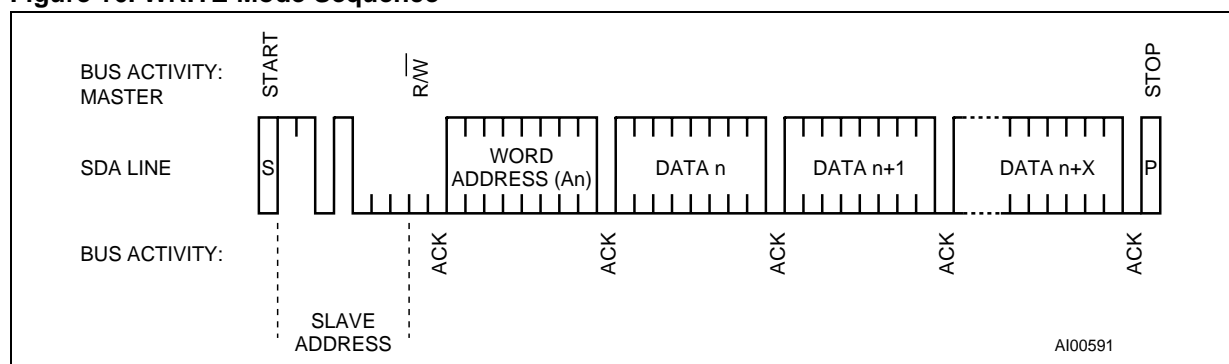
Symbol	Parameter ⁽¹⁾		Min	Max	Unit
f _{SCL}	SCL Clock Frequency		0	400	kHz
t _{BUF}	Time the bus must be free before a new transmission can start		1.3		μs
t _{EXPD}	$\overline{\text{EX}}$ to $\overline{\text{E}}_{\text{CON}}$ Propagation Delay	M41ST85Y		10	ns
		M41ST85W		15	
t _F	SDA and SCL Fall Time			300	ns
t _{HD:DAT} ⁽²⁾	Data Hold Time		0		μs
t _{HD:STA}	START Condition Hold Time (after this period the first clock pulse is generated)		600		ns
t _{HIGH}	Clock High Period		600		ns
t _{LOW}	Clock Low Period		1.3		μs
t _R	SDA and SCL Rise Time			300	ns
t _{SU:DAT}	Data Setup Time		100		ns
t _{SU:STA}	START Condition Setup Time (only relevant for a repeated start condition)		600		ns
t _{SU:STO}	STOP Condition Setup Time		600		ns

Note: 1. Valid for Ambient Operating Temperature: T_A = -40 to 85°C; V_{CC} = 4.5 to 5.5V or 2.7 to 3.6V (except where noted).
2. Transmitter must internally provide a hold time to bridge the undefined region (300ns max) of the falling edge of SCL.

Figure 15. Alternate READ Mode Sequence**WRITE Mode**

In this mode the master transmitter transmits to the M41ST85Y/W slave receiver. Bus protocol is shown in Figure 16, page 14. Following the START condition and slave address, a logic '0' ($R/W=0$) is placed on the bus and indicates to the addressed device that word address A_n will follow and is to be written to the on-chip address pointer. The data word to be written to the memory is

strobed in next and the internal address pointer is incremented to the next memory location within the RAM on the reception of an acknowledge clock. The M41ST85Y/W slave receiver will send an acknowledge clock to the master transmitter after it has received the slave address (see Figure 13, page 13) and again after it has received the word address and each data byte.

Figure 16. WRITE Mode Sequence

Data Retention Mode

With valid V_{CC} applied, the M41ST85Y/W can be accessed as described above with READ or WRITE Cycles. Should the supply voltage decay, the M41ST85Y/W will automatically deselect, write protecting itself (and any external SRAM) when V_{CC} falls between $V_{PFD(max)}$ and $V_{PFD(min)}$. This is accomplished by internally inhibiting access to the clock registers. At this time, the Reset pin (\overline{RST}) is driven active and will remain active until V_{CC} returns to nominal levels. External RAM access is inhibited in a similar manner by forcing \overline{ECON} to a high level. This level is within 0.2 volts of the V_{BAT} . \overline{ECON} will remain at this level as long as V_{CC} remains at an out-of-tolerance condition. When V_{CC} falls below the Battery Back-up Switchover Voltage (V_{SO}), power input is switched from the V_{CC} pin to the SNAPHAT[®] battery, and the clock registers and external SRAM are maintained from the attached battery supply.

All outputs become high impedance. The V_{OUT} pin is capable of supplying 100 μA of current to the attached memory with less than 0.3 volts drop under this condition. On power up, when V_{CC} returns to a nominal value, write protection continues for t_{REC} by inhibiting \overline{ECON} . The \overline{RST} signal also remains active during this time (see Figure 17, page 16).

Note: Most low power SRAMs on the market today can be used with the M41ST85Y/W RTC SUPERVISOR. There are, however some criteria which should be used in making the final choice of

an SRAM to use. The SRAM must be designed in a way where the chip enable input disables all other inputs to the SRAM. This allows inputs to the M41ST85Y/W and SRAMs to be "Don't Care" once V_{CC} falls below $V_{PFD(min)}$. The SRAM should also guarantee data retention down to $V_{CC}=2.0$ volts. The chip enable access time must be sufficient to meet the system needs with the chip enable output propagation delays included. If the SRAM includes a second chip enable pin ($E2$), this pin should be tied to V_{OUT} .

If data retention lifetime is a critical parameter for the system, it is important to review the data retention current specifications for the particular SRAMs being evaluated. Most SRAMs specify a data retention current at 3.0 volts. Manufacturers generally specify a typical condition for room temperature along with a worst case condition (generally at elevated temperatures). The system level requirements will determine the choice of which value to use. The data retention current value of the SRAMs can then be added to the I_{BAT} value of the M41ST85Y/W to determine the total current requirements for data retention. The available battery capacity for the SNAPHAT[®] of your choice can then be divided by this current to determine the amount of data retention available (see Table 15, page 27).

For a further more detailed review of lifetime calculations, please see Application Note AN1012.

Figure 17. Power Down/Up Mode AC Waveforms

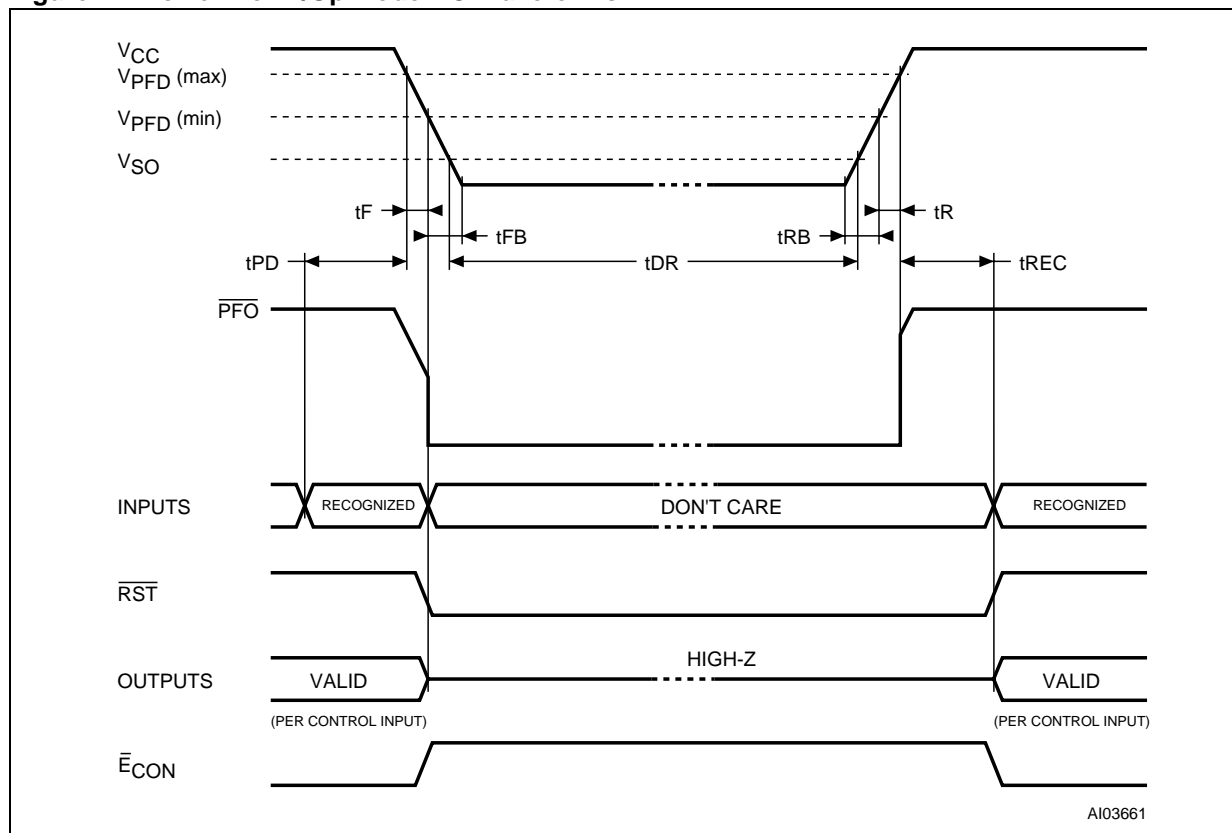


Table 7. Power Down/Up AC Characteristics

Symbol	Parameter ⁽¹⁾	Min	Typ	Max	Unit
$t_F^{(2)}$	$V_{PFD(max)}$ to $V_{PFD(min)}$ V_{CC} Fall Time	300			μs
$t_{FB}^{(3)}$	$V_{PFD(min)}$ to V_{SS} V_{CC} Fall Time	10			μs
t_{PD}	\overline{EX} at V_{IH} before Power Down	0			μs
t_{PFD}	PFI to PFO Propagation Delay		15	25	μs
t_R	$V_{PFD(min)}$ to $V_{PFD(max)}$ V_{CC} Rise Time	10			μs
t_{RB}	V_{SS} to $V_{PFD(min)}$ V_{CC} Rise Time	1			μs
$t_{REC}^{(4)}$	Power up Deselect Time	50		2000	μs

Note: 1. Valid for Ambient Operating Temperature: $T_A = -40$ to $85^\circ C$; $V_{CC} = 4.5$ to $5.5V$ or 2.7 to $3.6V$ (except where noted).

2. $V_{PFD(max)}$ to $V_{PFD(min)}$ fall time of less than t_F may result in deselection/write protection not occurring until $200\mu s$ after V_{CC} passes $V_{PFD(min)}$.

3. $V_{PFD(min)}$ to V_{SS} fall time of less than t_{FB} may cause corruption of RAM data.

4. Programmable (see Table 12, page 25)

CLOCK OPERATION

The eight byte clock register (see Table 8, page 18) is used to both set the clock and to read the date and time from the clock, in a binary coded decimal format. Tenths/Hundredths of Seconds, Seconds, Minutes, and Hours are contained within the first four registers.

Note: A WRITE to any clock register will result in the Tenths/Hundredths of Seconds being reset to "00," and Tenths/Hundredths of Seconds cannot be written to any value other than "00."

Bits D6 and D7 of Clock Register 03h (Century/Hours Register) contain the CENTURY ENABLE Bit (CEB) and the CENTURY Bit (CB). Setting CEB to a '1' will cause CB to toggle, either from '0' to '1' or from '1' to '0' at the turn of the century (depending upon its initial state). If CEB is set to a '0,' CB will not toggle. Bits D0 through D2 of Register 04h contain the Day (day of week). Registers 05h, 06h, and 07h contain the Date (day of month), Month and Years. The ninth clock register is the Control Register (this is described in the Clock Calibration section). Bit D7 of Register 01h contains the STOP Bit (ST). Setting this bit to a '1' will cause the oscillator to stop. If the device is expected to spend a significant amount of time on the shelf, the oscillator may be stopped to reduce current drain. When reset to a '0' the oscillator restarts within one second.

The eight Clock Registers may be read one byte at a time, or in a sequential block. The Control Register (Address location 08h) may be accessed independently. Provision has been made to assure that a clock update does not occur while any of the

eight clock addresses are being read. If a clock address is being read, an update of the clock registers will be halted. This will prevent a transition of data during the READ.

Note: When a power failure occurs, the Halt Update Bit (HT) will automatically be set to a '1.' This will prevent the clock from updating the TIMEKEEPER® registers, and will allow the user to read the exact time of the power-down event. Resetting the HT Bit to a '0' will allow the clock to update the TIMEKEEPER registers with the current time.

TIMEKEEPER® Registers

The M41ST85Y/W offers 20 internal registers which contain Clock, Alarm, Watchdog, Flag, Square Wave and Control data. These registers are memory locations which contain external (user accessible) and internal copies of the data (usually referred to as BiPORT™ TIMEKEEPER cells). The external copies are independent of internal functions except that they are updated periodically by the simultaneous transfer of the incremented internal copy. The internal divider (or clock) chain will be reset upon the completion of a WRITE to any clock address.

The system-to-user transfer of clock data will be halted whenever the address being read is a clock address (00h to 07h). The update will resume either due to a Stop Condition or when the pointer increments to a non-clock or RAM address.

TIMEKEEPER and Alarm Registers store data in BCD. Control, Watchdog and Square Wave Registers store data in Binary Format.

Table 8. TIMEKEEPER® Register Map

Address	Data								Function/Range BCD Format	
	D7	D6	D5	D4	D3	D2	D1	D0		
00h	0.1 Seconds				0.01 Seconds				Seconds	00-99
01h	ST	10 Seconds			Seconds				Seconds	00-59
02h	0	10 Minutes			Minutes				Minutes	00-59
03h	CEB	CB	10 Hours		Hours (24 Hour Format)				Century/Hours	0-1/00-23
04h	TR	0	0	0	0	Day of Week			Day	01-7
05h	0	0	10 Date		Date: Day of Month				Date	01-31
06h	0	0	0	10M	Month				Month	01-12
07h	10 Years				Year				Year	00-99
08h	OUT	FT	S	Calibration					Control	
09h	WDS	BMB4	BMB3	BMB2	BMB1	BMB0	RB1	RB0	Watchdog	
0Ah	AFE	SQWE	ABE	AI 10M	Alarm Month				AI Month	01-12
0Bh	RPT4	RPT5	AI 10 Date		Alarm Date				AI Date	01-31
0Ch	RPT3	HT	AI 10 Hour		Alarm Hour				AI Hour	00-23
0Dh	RPT2	Alarm 10 Minutes			Alarm Minutes				AI Min	00-59
0Eh	RPT1	Alarm 10 Seconds			Alarm Seconds				AI Sec	00-59
0Fh	WDF	AF	0	BL	0	0	0	0	Flags	
10h	0	0	0	0	0	0	0	0	Reserved	
11h	0	0	0	0	0	0	0	0	Reserved	
12h	0	0	0	0	0	0	0	0	Reserved	
13h	RS3	RS2	RS1	RS0	0	0	0	0	SQW	

Keys: S = Sign Bit

FT = Frequency Test Bit

ST = Stop Bit

0 = Must be set to zero

BL = Battery Low Flag (Read only)

BMB0-BMB4 = Watchdog Multiplier Bits

CEB = Century Enable Bit

CB = Century Bit

OUT = Output level

AFE = Alarm Flag Enable Flag

RB0-RB1 = Watchdog Resolution Bits

WDS = Watchdog Steering Bit

ABE = Alarm in Battery Back-Up Mode Enable Bit

RPT1-RPT5 = Alarm Repeat Mode Bits

WDF = Watchdog flag (Read only)

AF = Alarm flag (Read only)

SQWE = Square Wave Enable

RS0-RS3 = SQW Frequency

HT = Halt Update Bit

TR = t_{REC} Bit

Calibrating the Clock

The M41ST85Y/W is driven by a quartz controlled oscillator with a nominal frequency of 32,768 Hz. The devices are tested not exceed ± 35 PPM (parts per million) oscillator frequency error at 25°C, which equates to about ± 1.53 minutes per month. When the Calibration circuit is properly employed, accuracy improves to better than $\pm 1/2$ ppm at 25°C.

The oscillation rate of crystals changes with temperature (see Figure 21, page 26). Therefore, the M41ST85Y/W design employs periodic counter correction. The calibration circuit adds or subtracts counts from the oscillator divider circuit at the divide by 256 stage, as shown in Figure 22, page 26. The number of times pulses which are blanked (subtracted, negative calibration) or split (added, positive calibration) depends upon the value loaded into the five Calibration Bits found in the Control Register. Adding counts speeds the clock up, subtracting counts slows the clock down.

The Calibration Bits occupy the five lower order bits (D4-D0) in the Control Register (08h). These bits can be set to represent any value between 0 and 31 in binary form. Bit D5 is a Sign Bit; '1' indicates positive calibration, '0' indicates negative calibration. Calibration occurs within a 64 minute cycle. The first 62 minutes in the cycle may, once per minute, have one second either shortened by 128 or lengthened by 256 oscillator cycles. If a binary '1' is loaded into the register, only the first 2 minutes in the 64 minute cycle will be modified; if a binary 6 is loaded, the first 12 will be affected, and so on.

Therefore, each calibration step has the effect of adding 512 or subtracting 256 oscillator cycles for every 125,829,120 actual oscillator cycles, that is $+4.068$ or -2.034 PPM of adjustment per calibration step in the calibration register. Assuming that the oscillator is running at exactly 32,768 Hz, each of the 31 increments in the Calibration byte would represent $+10.7$ or -5.35 seconds per month which corresponds to a total range of $+5.5$ or -2.75 minutes per month.

Two methods are available for ascertaining how much calibration a given M41ST85Y/W may require.

The first involves setting the clock, letting it run for a month and comparing it to a known accurate reference and recording deviation over a fixed period of time. Calibration values, including the number of seconds lost or gained in a given period, can be found in Application Note AN934, "TIMEKEEPER® CALIBRATION." This allows the designer to give the end user the ability to calibrate the clock as the environment requires, even if the final prod-

uct is packaged in a non-user serviceable enclosure. The designer could provide a simple utility that accesses the Calibration byte.

The second approach is better suited to a manufacturing environment, and involves the use of the $\overline{\text{IRQ/FT/OUT}}$ pin. The pin will toggle at 512Hz, when the Stop Bit (ST, D7 of 01h) is '0,' the Frequency Test Bit (FT, D6 of 08h) is '1,' the Alarm Flag Enable Bit (AFE, D7 of 0Ah) is '0,' and the Watchdog Steering Bit (WDS, D7 of 09h) is '1' or the Watchdog Register (09h = 0) is reset.

Any deviation from 512 Hz indicates the degree and direction of oscillator frequency shift at the test temperature. For example, a reading of 512.010124 Hz would indicate a $+20$ PPM oscillator frequency error, requiring a -10 (XX001010) to be loaded into the Calibration Byte for correction. Note that setting or changing the Calibration Byte does not affect the Frequency test output frequency.

The $\overline{\text{IRQ/FT/OUT}}$ pin is an open drain output which requires a pull-up resistor to V_{CC} for proper operation. A 500 to 10k resistor is recommended in order to control the rise time. The FT Bit is cleared on power-down.

Setting Alarm Clock Registers

Address locations 0Ah-0Eh contain the alarm settings. The alarm can be configured to go off at a prescribed time on a specific month, date, hour, minute, or second, or repeat every year, month, day, hour, minute, or second. It can also be programmed to go off while the M41ST85Y/W is in the battery back-up to serve as a system wake-up call.

Bits RPT5–RPT1 put the alarm in the repeat mode of operation. Table 9, page 20 shows the possible configurations. Codes not listed in the table default to the once per second mode to quickly alert the user of an incorrect alarm setting.

When the clock information matches the alarm clock settings based on the match criteria defined by RPT5–RPT1, the AF (Alarm Flag) is set. If AFE (Alarm Flag Enable) is also set, the alarm condition activates the $\overline{\text{IRQ/FT/OUT}}$ pin as shown in Figure 18, page 20. To disable alarm, write '0' to the Alarm Date Register and to RPT5–RPT1.

Note: If the address pointer is allowed to increment to the Flag Register address, an alarm condition will not cause the Interrupt/Flag to occur until the address pointer is moved to a different address. It should also be noted that if the last address written is the "Alarm Seconds," the address pointer will increment to the Flag address, causing this situation to occur.

The $\overline{\text{IRQ/FT/OUT}}$ output is cleared by a READ to the Flags Register. A subsequent READ of the Flags Register is necessary to see that the value of the Alarm Flag has been reset to '0.'

The $\overline{\text{IRQ/FT/OUT}}$ pin can also be activated in the battery back-up mode. The $\overline{\text{IRQ/FT/OUT}}$ will go low if an alarm occurs and both ABE (Alarm in Battery Back-up Mode Enable) and AFE are set. The

ABE and AFE Bits are reset during power-up, therefore an alarm generated during power-up will only set AF. The user can read the Flag Register at system boot-up to determine if an alarm was generated while the M41ST85Y/W was in the de-select mode during power-up. Figure 19, page 21 illustrates the back-up mode alarm timing.

Figure 18. Alarm Interrupt Reset Waveform

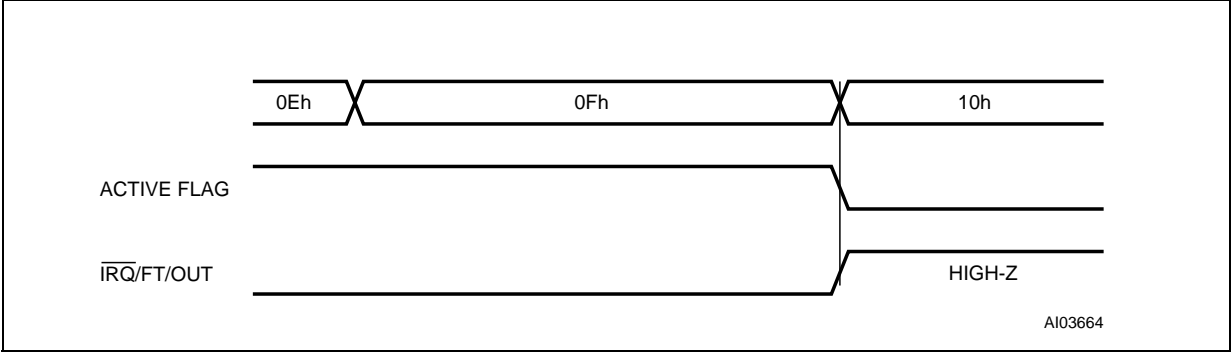
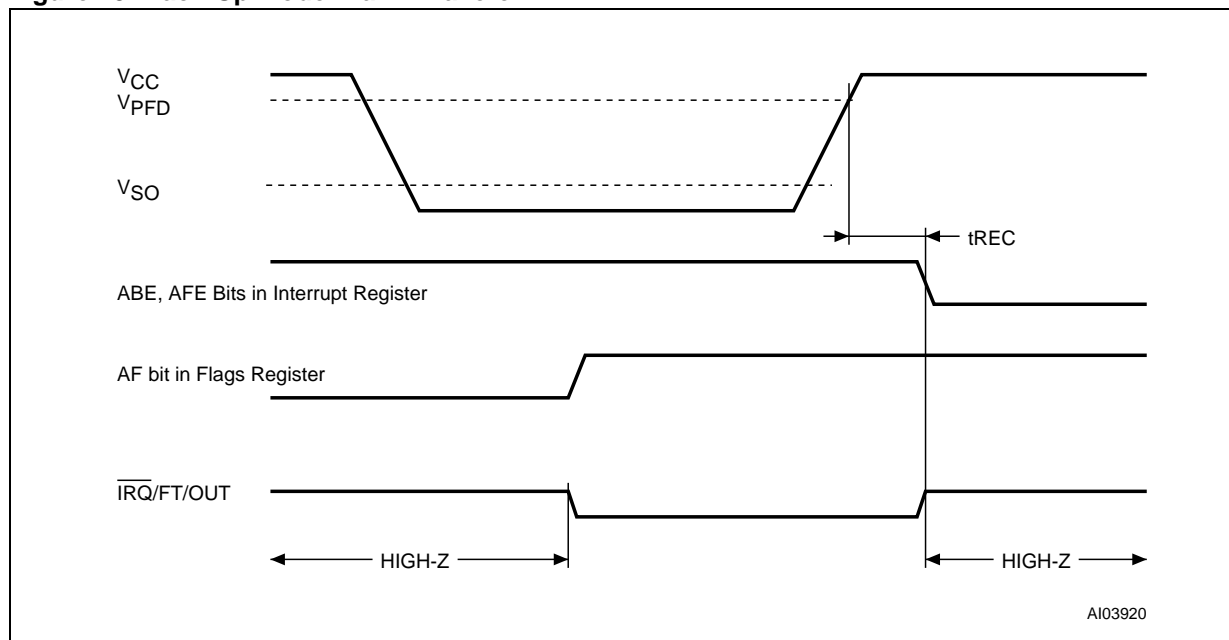


Table 9. Alarm Repeat Modes

RPT5	RPT4	RPT3	RPT2	RPT1	Alarm Setting
1	1	1	1	1	Once per Second
1	1	1	1	0	Once per Minute
1	1	1	0	0	Once per Hour
1	1	0	0	0	Once per Day
1	0	0	0	0	Once per Month
0	0	0	0	0	Once per Year

Figure 19. Back-Up Mode Alarm Waveform

AI03920

Watchdog Timer

The watchdog timer can be used to detect an out-of-control microprocessor. The user programs the watchdog timer by setting the desired amount of time-out into the Watchdog Register, address 09h. Bits BMB4-BMB0 store a binary multiplier and the two lower order bits RB1-RB0 select the resolution, where 00=1/16 second, 01=1/4 second, 10=1 second, and 11=4 seconds. The amount of time-out is then determined to be the multiplication of the five-bit multiplier value with the resolution. (For example: writing 00001110 in the Watchdog Register = 3×1 or 3 seconds).

Note: The accuracy of the timer is within \pm the selected resolution.

If the processor does not reset the timer within the specified period, the M41ST85Y/W sets the WDF (Watchdog Flag) and generates a watchdog interrupt or a microprocessor reset.

The most significant bit of the Watchdog Register is the Watchdog Steering Bit (WDS). When set to a '0,' the watchdog will activate the $\overline{IRQ/FT/OUT}$ pin when timed-out. When WDS is set to a '1,' the watchdog will output a negative pulse on the RST pin for t_{REC} . The Watchdog register, FT, AFE, ABE and SQWE Bits will reset to a '0' at the end of a Watchdog time-out when the WDS Bit is set to a '1.'

The watchdog timer can be reset by two methods: 1) a transition (high-to-low or low-to-high) can be applied to the Watchdog Input pin (WDI) or 2) the microprocessor can perform a WRITE of the Watchdog Register. The time-out period then starts over.

Note: The WDI pin should be tied to V_{SS} if not used.

In order to perform a software reset of the watchdog timer, the original time-out period can be written into the Watchdog Register, effectively restarting the count-down cycle.

Should the watchdog timer time-out, and the WDS Bit is programmed to output an interrupt, a value of 00h needs to be written to the Watchdog Register in order to clear the $\overline{IRQ/FT/OUT}$ pin. This will also disable the watchdog function until it is again programmed correctly. A READ of the Flags Register will reset the Watchdog Flag (Bit D7; Register 0Fh).

The watchdog function is automatically disabled upon power-up and the Watchdog Register is cleared. If the watchdog function is set to output to the $\overline{IRQ/FT/OUT}$ pin and the frequency test function is activated, the watchdog function prevails and the frequency test function is denied.

Square Wave Output

The M41ST85Y/W offers the user a programmable square wave function which is output on the SQW pin. RS3-RS0 bits located in 13h establish the square wave output frequency. These frequencies are listed in Table 10. Once the selection

of the SQW frequency has been completed, the SQW pin can be turned on and off under software control with the Square Wave Enable Bit (SQWE) located in Register 0Ah.

Table 10. Square Wave Output Frequency

Square Wave Bits				Square Wave	
RS3	RS2	RS1	RS0	Frequency	Units
0	0	0	0	None	–
0	0	0	1	32.768	kHz
0	0	1	0	8.192	kHz
0	0	1	1	4.096	kHz
0	1	0	0	2.048	kHz
0	1	0	1	1.024	kHz
0	1	1	0	512	Hz
0	1	1	1	256	Hz
1	0	0	0	128	Hz
1	0	0	1	64	Hz
1	0	1	0	32	Hz
1	0	1	1	16	Hz
1	1	0	0	8	Hz
1	1	0	1	4	Hz
1	1	1	0	2	Hz
1	1	1	1	1	Hz

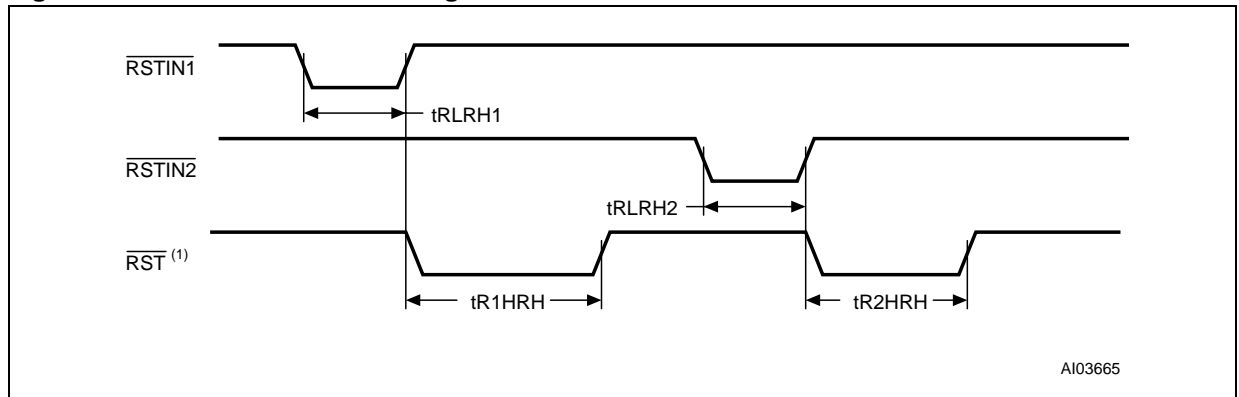
Power-on Reset

The M41ST85Y/W continuously monitors V_{CC} . When V_{CC} falls to the power fail detect trip point, the \overline{RST} pulls low (open drain) and remains low on power-up for t_{REC} after V_{CC} passes $V_{PFD(max)}$. The \overline{RST} pin is an open drain output and an appropriate pull-up resistor should be chosen to control rise time.

Reset Inputs ($\overline{RSTIN1}$ & $\overline{RSTIN2}$)

The M41ST85Y/W provides two independent inputs which can generate an output reset. The duration and function of these resets is identical to a reset generated by a power cycle. Table 11 and Figure 20 illustrate the AC reset characteristics of this function. Pulses shorter than t_{RLRH1} and t_{RLRH2} will not generate a reset condition. $\overline{RSTIN1}$ and $\overline{RSTIN2}$ are each internally pulled up to V_{CC} through a 100k Ω resistor.

Figure 20. $\overline{RSTIN1}$ & $\overline{RSTIN2}$ Timing Waveforms



Note: With pull-up resistor

Table 11. Reset AC Characteristics

Symbol	Parameter ⁽¹⁾	Min	Max	Unit
$t_{RLRH1}^{(2)}$	$\overline{RSTIN1}$ Low to $\overline{RSTIN1}$ High	200		ns
$t_{RLRH2}^{(3)}$	$\overline{RSTIN2}$ Low to $\overline{RSTIN2}$ High	100		ms
$t_{R1HRH}^{(4)}$	$\overline{RSTIN1}$ High to \overline{RST} High	50	2000	μ s
$t_{R2HRH}^{(4)}$	$\overline{RSTIN2}$ High to \overline{RST} High	50	2000	μ s

Note: 1. Valid for Ambient Operating Temperature: $T_A = -40$ to 85°C ; $V_{CC} = 4.5$ to 5.5V or 2.7 to 3.6V (except where noted).

2. Pulse width less than 50ns will result in no RESET (for noise immunity).

3. Pulse width less than 20ms will result in no RESET (for noise immunity).

4. Programmable (see Table 12, page 25).

Power-fail INPUT/OUTPUT

The Power-Fail Input (PFI) is compared to an internal reference voltage (1.25V). If PFI is less than the power-fail threshold (V_{PFI}), the Power-Fail Output (PFO) will go low. This function is intended for use as an undervoltage detector to signal a failing power supply. Typically PFI is connected through an external voltage divider (see Figure 7, page 7) to either the unregulated DC input (if it is available) or the regulated output of the V_{CC} regulator. The voltage divider can be set up such that the voltage at PFI falls below V_{PFI} several milliseconds before the regulated V_{CC} input to the M41ST85Y/W or the microprocessor drops below the minimum operating voltage.

During battery back-up, the power-fail comparator turns off and PFO goes (or remains) low. This occurs after V_{CC} drops below $V_{PFD}(\min)$. When power returns, PFO is forced high, irrespective of V_{PFI} for the write protect time (t_{REC}), which is the time from $V_{PFD}(\max)$ until the inputs are recognized. At the end of this time, the power-fail comparator is enabled and PFO follows PFI. If the comparator is unused, PFI should be connected to V_{SS} and PFO left unconnected.

Century Bit

Bits D7 and D6 of Clock Register 03h contain the CENTURY ENABLE Bit (CEB) and the CENTURY Bit (CB). Setting CEB to a '1' will cause CB to toggle, either from a '0' to '1' or from '1' to '0' at the turn of the century (depending upon its initial state). If CEB is set to a '0', CB will not toggle.

Output Driver Pin

When the FT Bit, AFE Bit and watchdog register are not set, the IRQ/FT/OUT pin becomes an output driver that reflects the contents of D7 of the Control Register. In other words, when D7 (OUT Bit) and D6 (FT Bit) of address location 08h are a '0', then the IRQ/FT/OUT pin will be driven low.

Note: The $\overline{\text{IRQ/FT/OUT}}$ pin is an open drain which requires an external pull-up resistor.

Battery Low Warning

The M41ST85Y/W automatically performs battery voltage monitoring upon power-up and at factory-programmed time intervals of approximately 24 hours. The Battery Low (BL) Bit, Bit D4 of Flags Register 0Fh, will be asserted if the battery voltage is found to be less than approximately 2.5V. The

BL Bit will remain asserted until completion of battery replacement and subsequent battery low monitoring tests, either during the next power-up sequence or the next scheduled 24-hour interval.

If a battery low is generated during a power-up sequence, this indicates that the battery is below approximately 2.5 volts and may not be able to maintain data integrity in the SRAM. Data should be considered suspect and verified as correct. A fresh battery should be installed.

If a battery low indication is generated during the 24-hour interval check, this indicates that the battery is near end of life. However, data is not compromised due to the fact that a nominal V_{CC} is supplied. In order to insure data integrity during subsequent periods of battery back-up mode, the battery should be replaced. The SNAPHAT top may be replaced while V_{CC} is applied to the device.

Note: This will cause the clock to lose time during the interval the SNAPHAT battery/crystal top is disconnected.

The M41ST85Y/W only monitors the battery when a nominal V_{CC} is applied to the device. Thus applications which require extensive durations in the battery back-up mode should be powered-up periodically (at least once every few months) in order for this technique to be beneficial. Additionally, if a battery low is indicated, data integrity should be verified upon power-up via a checksum or other technique.

 t_{REC} Bit

Bit D7 of Clock Register 04h contains the t_{REC} Bit (TR). t_{REC} refers to the automatic continuation of the deselect time after V_{CC} reaches V_{PFD} . This allows for a voltage settling time before WRITES may again be performed to the device after a power-down condition. The t_{REC} Bit will allow the user to set the length of this deselect time as defined by Table 12, page 25.

Initial Power-on Defaults

Upon initial application of power to the device, the following register bits are set to a '0' state: Watchdog Register, FT, AFE, ABE, and SQWE. The following bits are set to a '1' state: ST, OUT, TR, and HT (see Table 13, page 25).

Table 12. t_{REC} Definitions

t _{REC} Bit (TR)	STOP Bit (ST)	t _{REC} Time		Units
		Min	Max	
0	0	96	98	ms
0	1	40	200	ms
1	X	50	2000 ⁽¹⁾	μs

Note: 1. Default Setting

Table 13. Default Values

Condition	TR	ST	HT	Out	FT	AFE	ABE	SQWE	WATCHDOG Register ⁽¹⁾
Initial Power-up ⁽²⁾	1	1	1	1	0	0	0	0	0
Subsequent Power-up (with battery back-up) ⁽³⁾	UC	UC	1	UC	0	0	0	0	0

Note: 1. WDS, BMB0-BMB4, RB0, RB1.
 2. State of other control bits undefined.
 3. UC = Unchanged

Figure 21. Crystal Accuracy Across Temperature

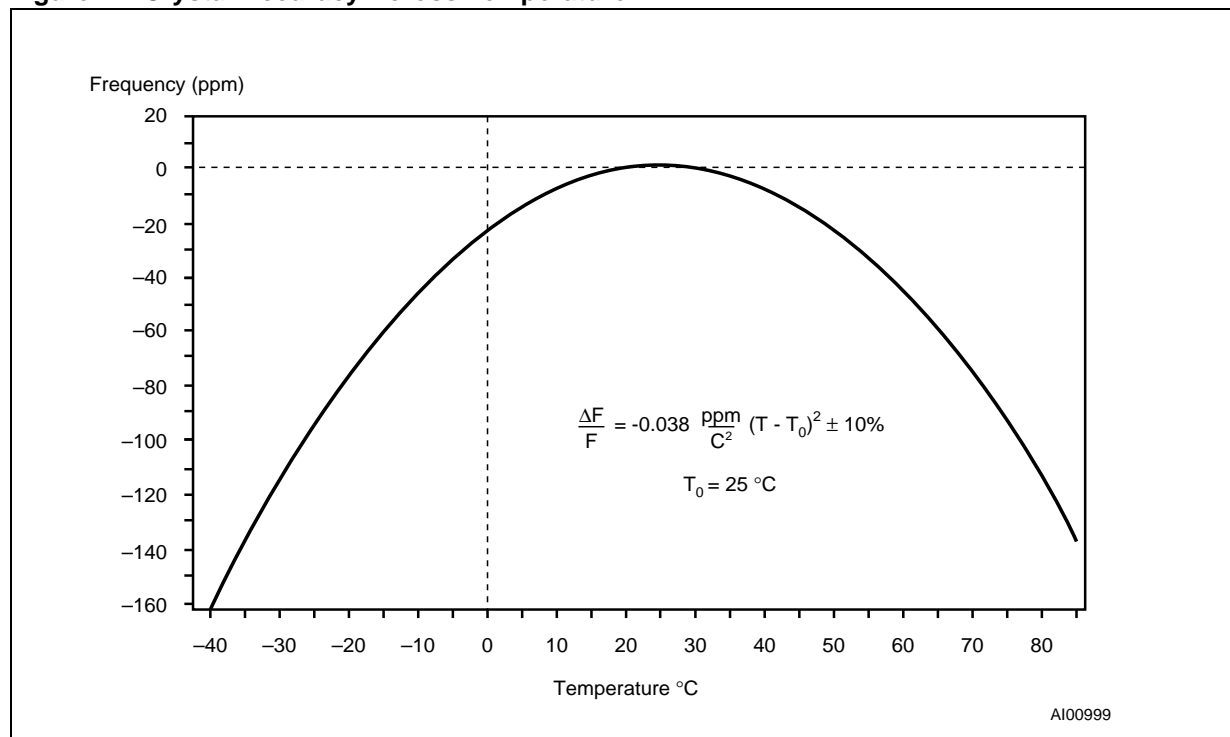
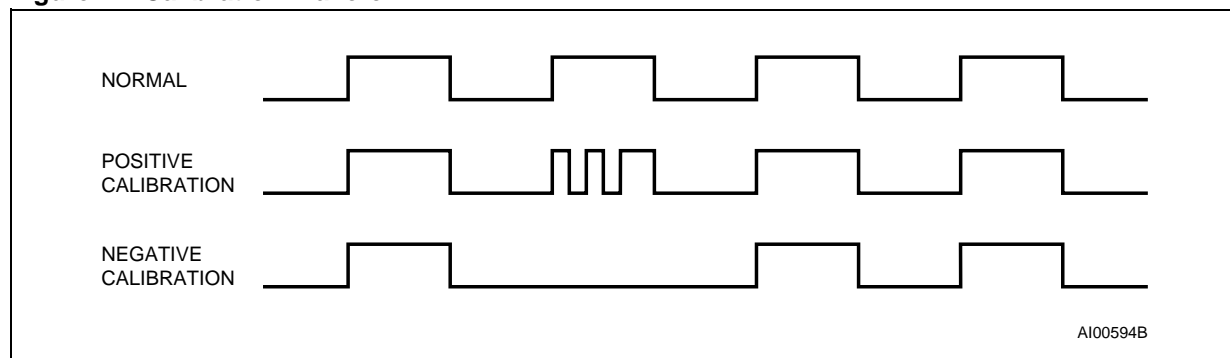


Figure 22. Calibration Waveform



PART NUMBERING

Table 14. Ordering Information Scheme

Example:	M41ST	85Y	MH	6	TR
Device Type					
M41ST					
Supply Voltage and Write Protect Voltage					
85Y = $V_{CC} = 4.5$ to $5.5V$; $4.20V \leq V_{PFD} \leq 4.50V$					
85W = $V_{CC} = 2.7$ to $3.6V$; $2.55V \leq V_{PFD} \leq 2.70V$					
Package					
MH ⁽¹⁾ = SOH28					
MX ⁽²⁾ = SOX28					
Temperature Range					
6 = -40 to $85^{\circ}C$					
Shipping Method for SOIC					
blank = Tubes					
TR = Tape & Reel					

Note: 1. The 28-pin SOIC package (SOH28) requires the battery/crystal package (SNAPHAT[®]) which is ordered separately under the part number "M4TXX-BR12SHX" in plastic tube or "M4TXX-BR12SHXTR" in Tape & Reel form.
 2. The SOX28 package includes an embedded 32,768Hz crystal.

Caution: Do not place the SNAPHAT battery package "M4TXX-BR12SH" in conductive foam as it will drain the lithium button-cell battery.

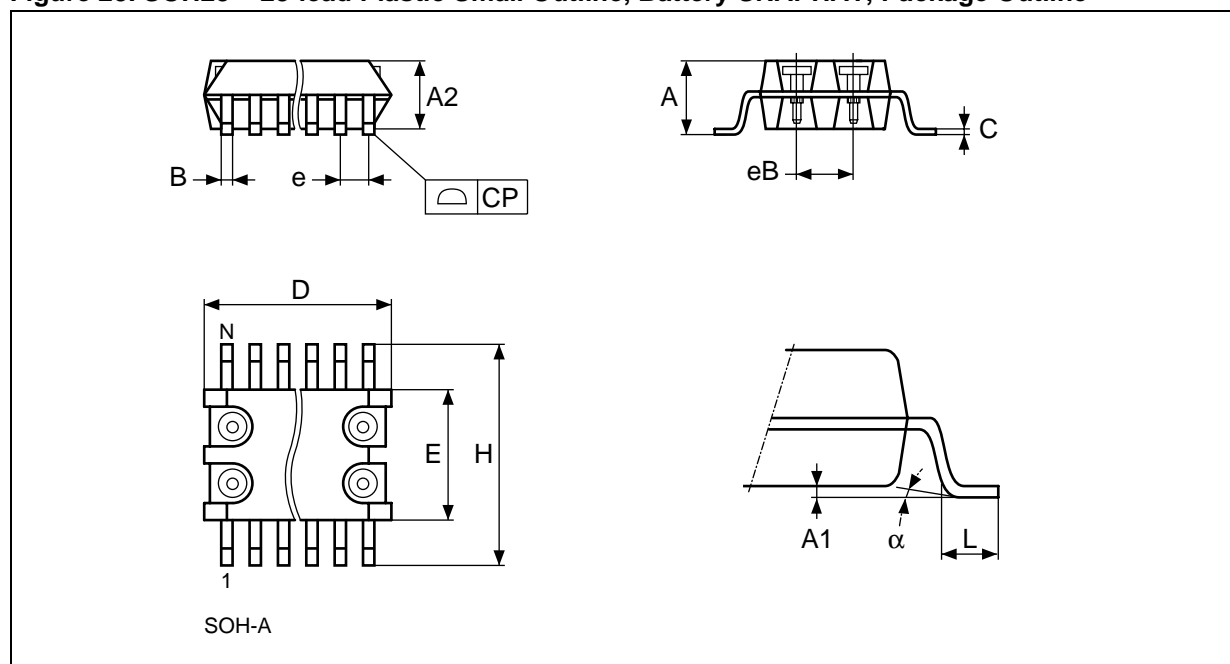
For a list of available options (e.g., Speed, Package) or for further information on any aspect of this device, please contact the ST Sales Office nearest to you.

Table 15. SNAPHAT Battery Table

Part Number	Description	Package
M4T28-BR12SH	Lithium Battery (48mAh) and Crystal SNAPHAT	SH
M4T32-BR12SH	Lithium Battery (120mAh) and Crystal SNAPHAT	SH

PACKAGE MECHANICAL INFORMATION

Figure 23. SOH28 – 28-lead Plastic Small Outline, Battery SNAPHAT, Package Outline

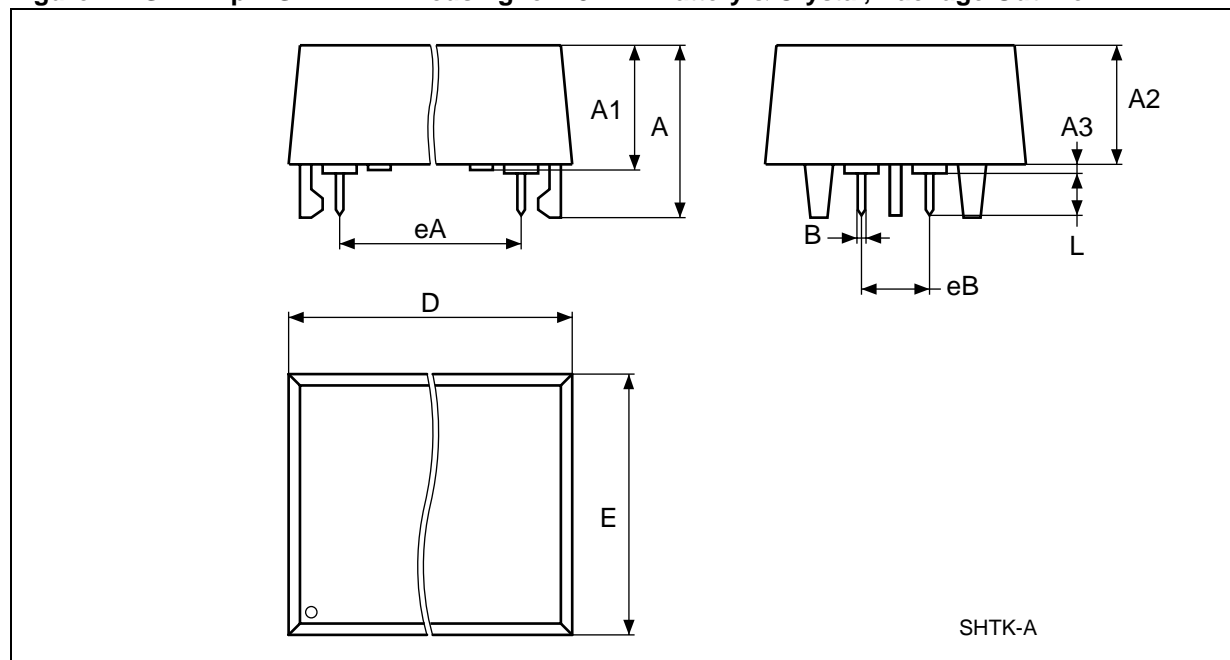


Note: Drawing is not to scale.

Table 16. SOH28 – 28-lead Plastic Small Outline, battery SNAPHAT, Package Mechanical Data

Symbol	millimeters			inches		
	Typ	Min	Max	Typ	Min	Max
A			3.05			0.120
A1		0.05	0.36		0.002	0.014
A2		2.34	2.69		0.092	0.106
B		0.36	0.51		0.014	0.020
C		0.15	0.32		0.006	0.012
D		17.71	18.49		0.697	0.728
E		8.23	8.89		0.324	0.350
e	1.27	–	–	0.050	–	–
eB		3.20	3.61		0.126	0.142
H		11.51	12.70		0.453	0.500
L		0.41	1.27		0.016	0.050
α		0°	8°		0°	8°
N	28			28		
CP			0.10			0.004

Figure 24. SH – 4-pin SNAPHAT Housing for 48mAh Battery & Crystal, Package Outline

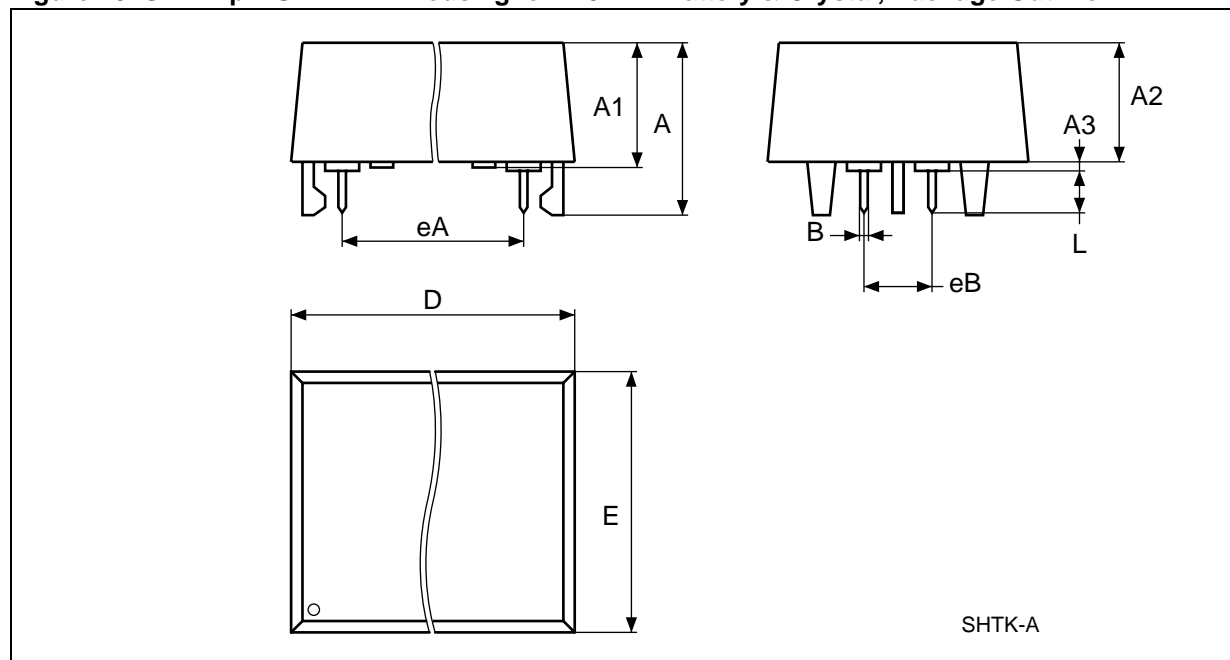


Note: Drawing is not to scale.

Table 17. SH – 4-pin SNAPHAT Housing for 48mAh Battery & Crystal, Package Mechanical Data

Symbol	millimeters			inches		
	Typ	Min	Max	Typ	Min	Max
A			9.78			0.3850
A1		6.73	7.24		0.2650	0.2850
A2		6.48	6.99		0.2551	0.2752
A3			0.38			0.0150
B		0.46	0.56		0.0181	0.0220
D		21.21	21.84		0.8350	0.8598
E		14.22	14.99		0.5598	0.5902
eA		15.55	15.95		0.6122	0.6280
eB		3.20	3.61		0.1260	0.1421
L		2.03	2.29		0.0799	0.0902

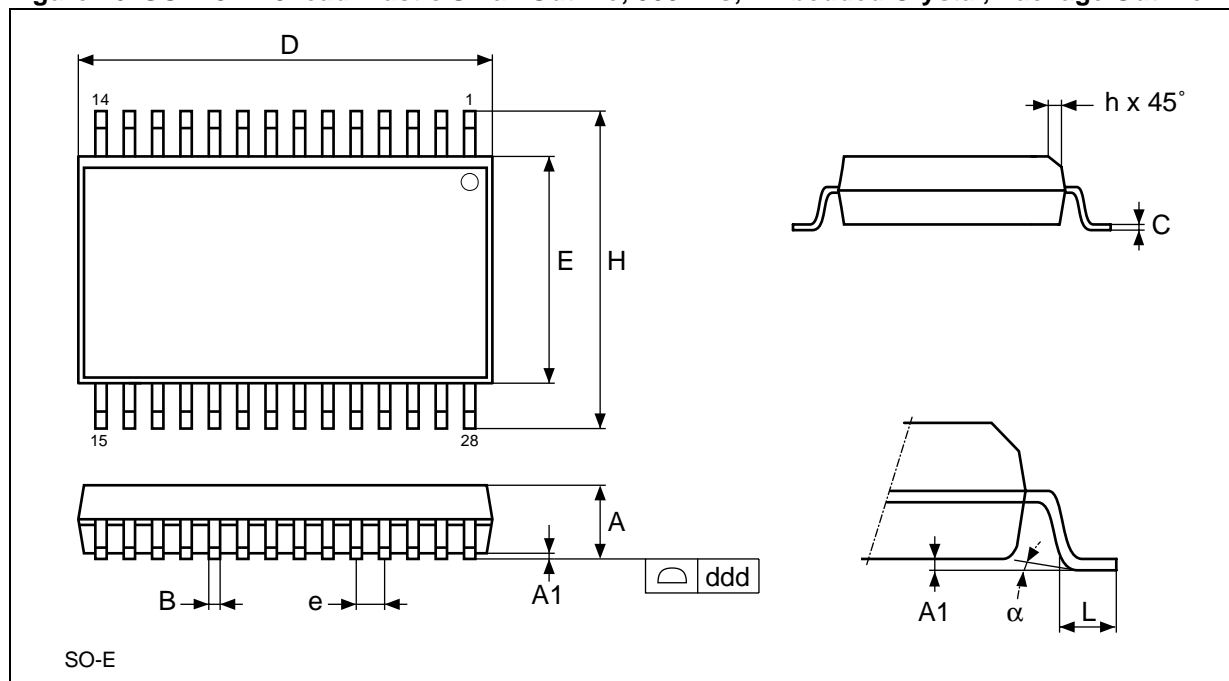
Figure 25. SH – 4-pin SNAPHAT Housing for 120mAh Battery & Crystal, Package Outline



Note: Drawing is not to scale.

Table 18. SH – 4-pin SNAPHAT Housing for 120mAh Battery & Crystal, Package Mechanical Data

Symbol	millimeters			inches		
	Typ	Min	Max	Typ	Min	Max
A			10.54			0.4150
A1		6.73	7.24		0.2650	0.2850
A2		6.48	6.99		0.2551	0.2752
A3			0.38			0.0150
B		0.46	0.56		0.0181	0.0220
D		21.21	21.84		0.8350	0.8598
E		14.22	14.99		0.5598	0.5902
eA		15.55	15.95		0.6122	0.6280
eB		3.20	3.61		0.1260	0.1421
L		2.03	2.29		0.0799	0.0902

Figure 26. SOX28 – 28-lead Plastic Small Outline, 300mils, Embedded Crystal, Package Outline

Note: Drawing is not to scale.

Table 19. SOX28 – 28-lead Plastic Small Outline, 300mils, Embedded Crystal, Package Mechanical

Symbol	millimeters			inches		
	Typ	Min	Max	Typ	Min	Max
A		2.35	2.65		0.093	0.104
A1		0.10	0.30		0.004	0.012
B		0.33	0.51		0.013	0.020
C		0.23	0.32		0.009	0.013
D		17.70	18.10		0.697	0.713
E		7.40	7.60		0.291	0.299
e	1.27	–	–	0.050	–	–
H		10.00	10.65		0.394	0.419
L		0.40	1.27		0.016	0.050
α		0°	8°		0°	8°
N		28			28	
ddd			0.10			0.004

REVISION HISTORY**Table 20. Document Revision History**

Date	Rev. #	Revision Details
August 2000	1.0	First issue
08/24/00	1.1	Block Diagram added (Figure 3)
10/12/00	1.2	t _{REC} Table removed, cross references corrected
12/18/00	2.0	Reformatted, TOC added, and PFI Input Leakage Current added (Table 5)
06/18/01	2.1	Addition of t _{REC} information, table changed, one added (Tables 8, 12); changed PFI/PFO graphic (see Figure 6); change to DC and AC Characteristics, Order Information (Tables 5, 6, 14); note added to "Setting Alarm Clock Registers" section; added temp./voltage info. to tables (Table 4, 5, 6, 6, 7); addition of Default Values (Table 13)
6/22/01	2.2	Note added to Clock Operation section
07/26/01	3.0	Change in Product Maturity
08/07/01	3.1	Improve text in "Setting the Alarm Clock" section
08/20/01	3.2	Change V _{PFD} values in document
09/06/01	3.3	DC Characteristics V _{BAT} changed; V _{OHB} changed; PFI Hysteresis (PFI Rising) spec. added; and Crystal Electrical Characteristics table removed (Tables 5, 6)
12/03/01	3.4	Changed READ/WRITE Mode Sequences (Figure 14, 16); change in V _{PFD} lower limit for 5V (M41ST85Y) part only (Table 5, 14)
05/01/02	3.5	Change t _{REC} Definition (Table 12); modify reflow time and temperature footnote (Table 2)
07/03/02	3.6	Modify DC Characteristics table footnote, Default Values (Tables 5, 13)
11/15/02	3.7	Added embedded crystal (MX) package option; corrected initial power-up condition (Figure 2, 3, 5, 6, 7, 26, Table 1, 13, 14, 19)
01/24/03	3.8	Update diagrams (Figure 6, 7, 26); update values (Table 7, 11, 12, 13, 19)

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